Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/725,668	BRENNAN ET AL.
Examiner	**Art Unit**
John P. Trimmings	2138

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)	DATE	EXMR
NPL Search: self test repair redundant embedded memory.	3/27/2006	JPT
Dble Patent Search: Negative.	3/27/2006	JPT
Class Search: 714/733,30,7,710,711, 718,719,721,723,745,734. Text strategy attached.	3/27/2006	JPT